

FIG. 1

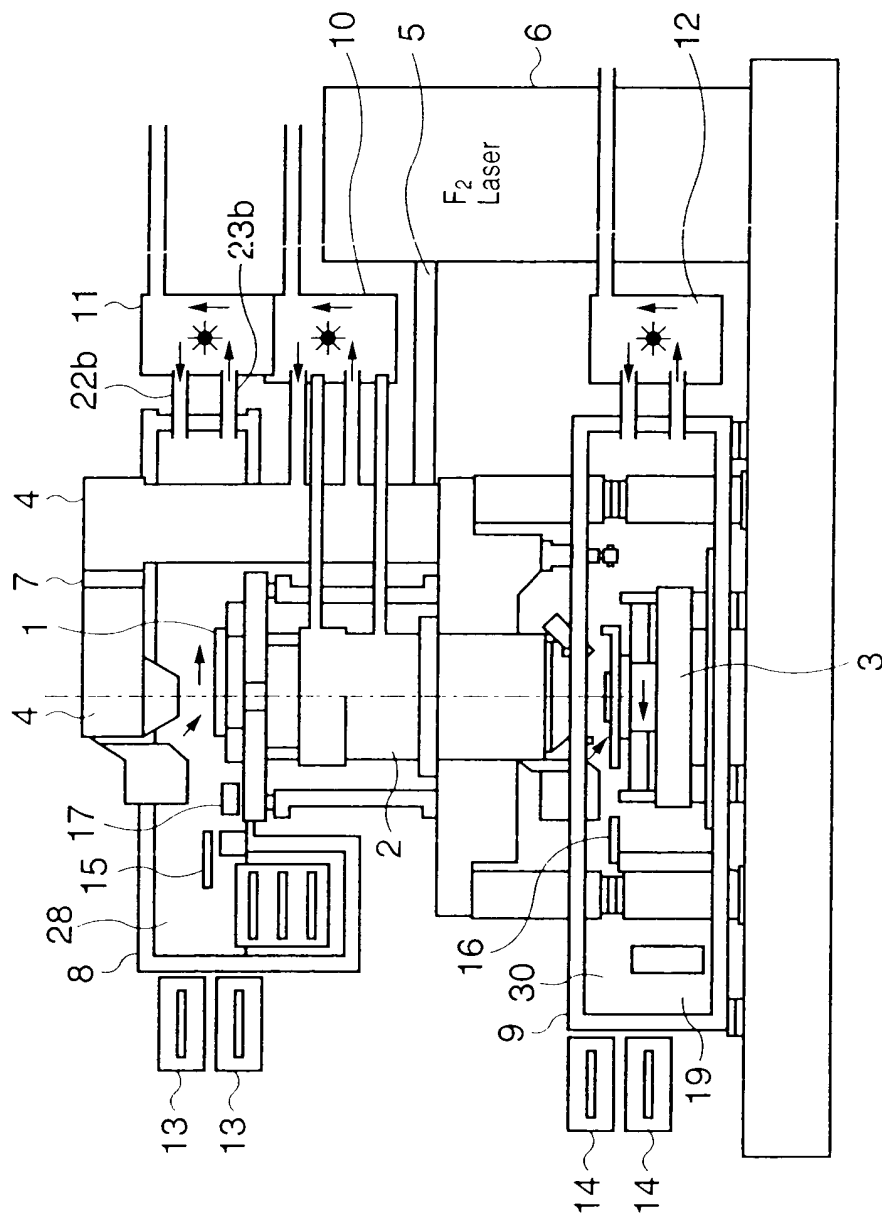


FIG. 2

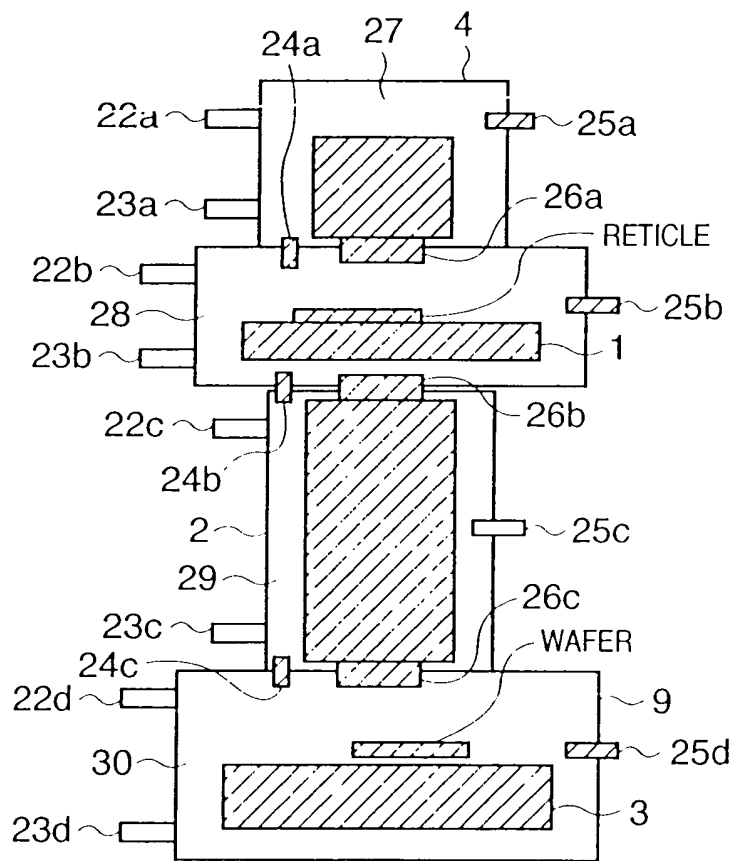


FIG. 3

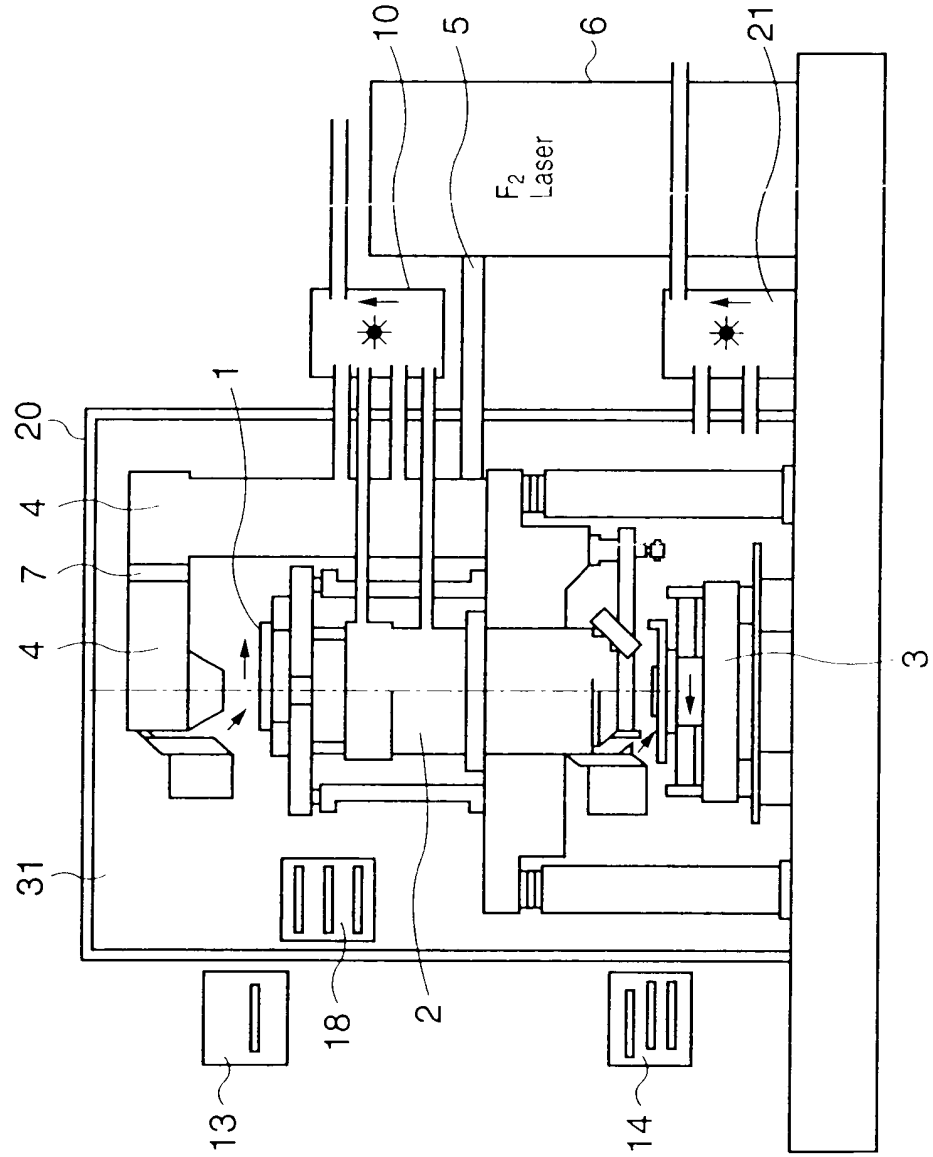


FIG. 4

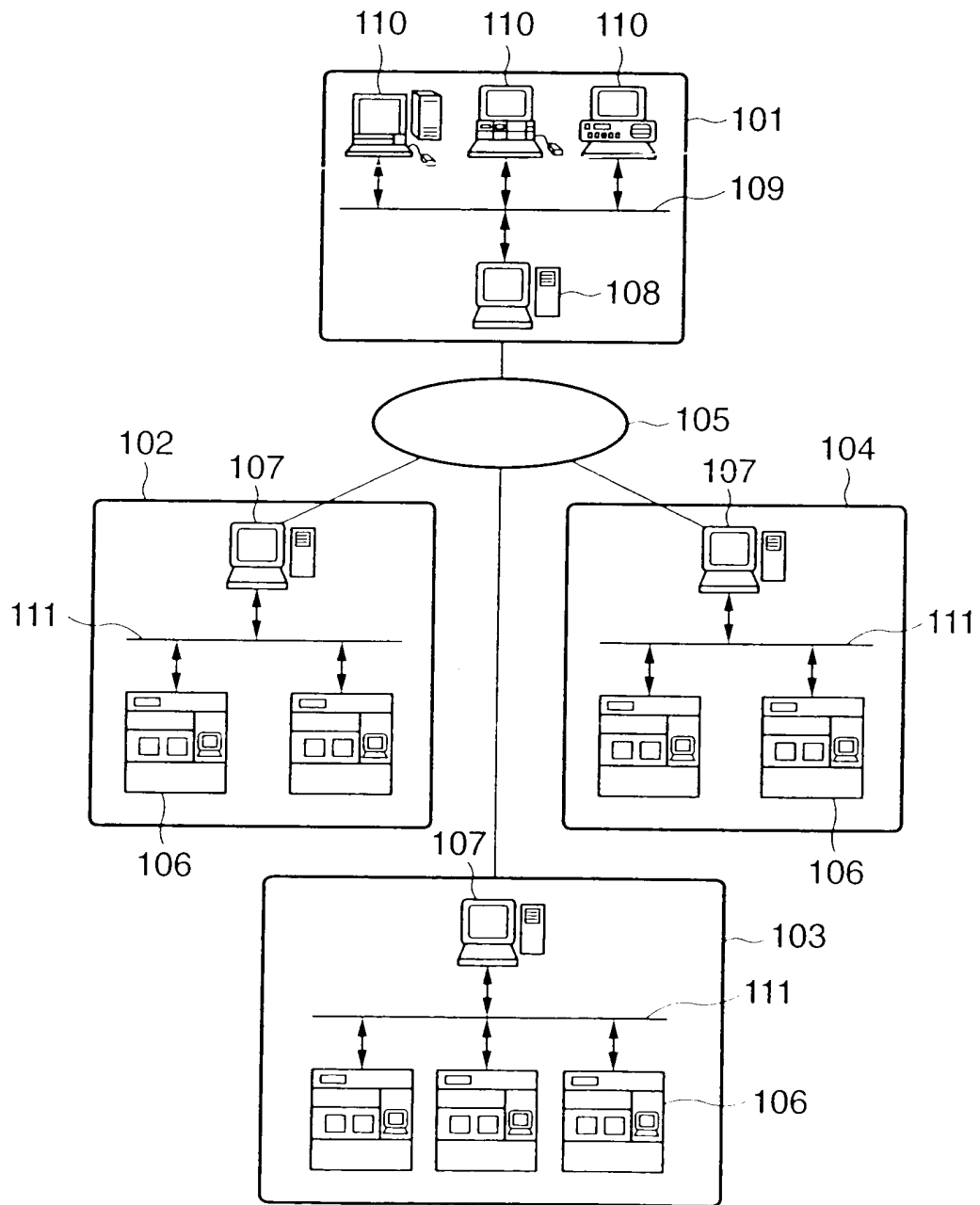


FIG. 5

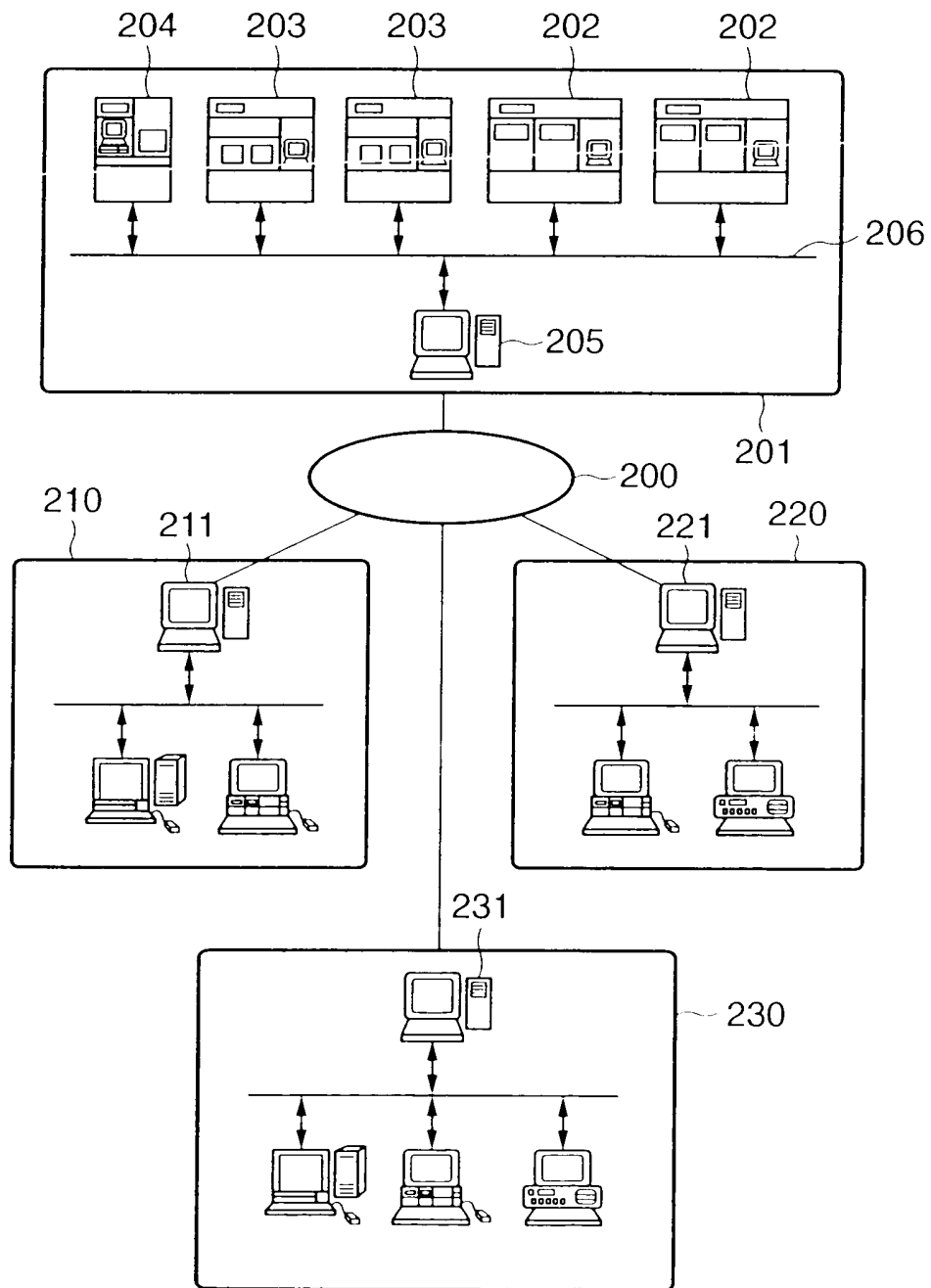


FIG. 6

URL

MALFUNCTION DATABASE INPUT SCREEN

DATE OF OCCURRENCE ~ 404

MODEL ~ 401

SUBJECT MATTER ~ 403

EQUIPMENT SERIAL NO. S/N ~ 402

DEGREE OF URGENCY ~ 405

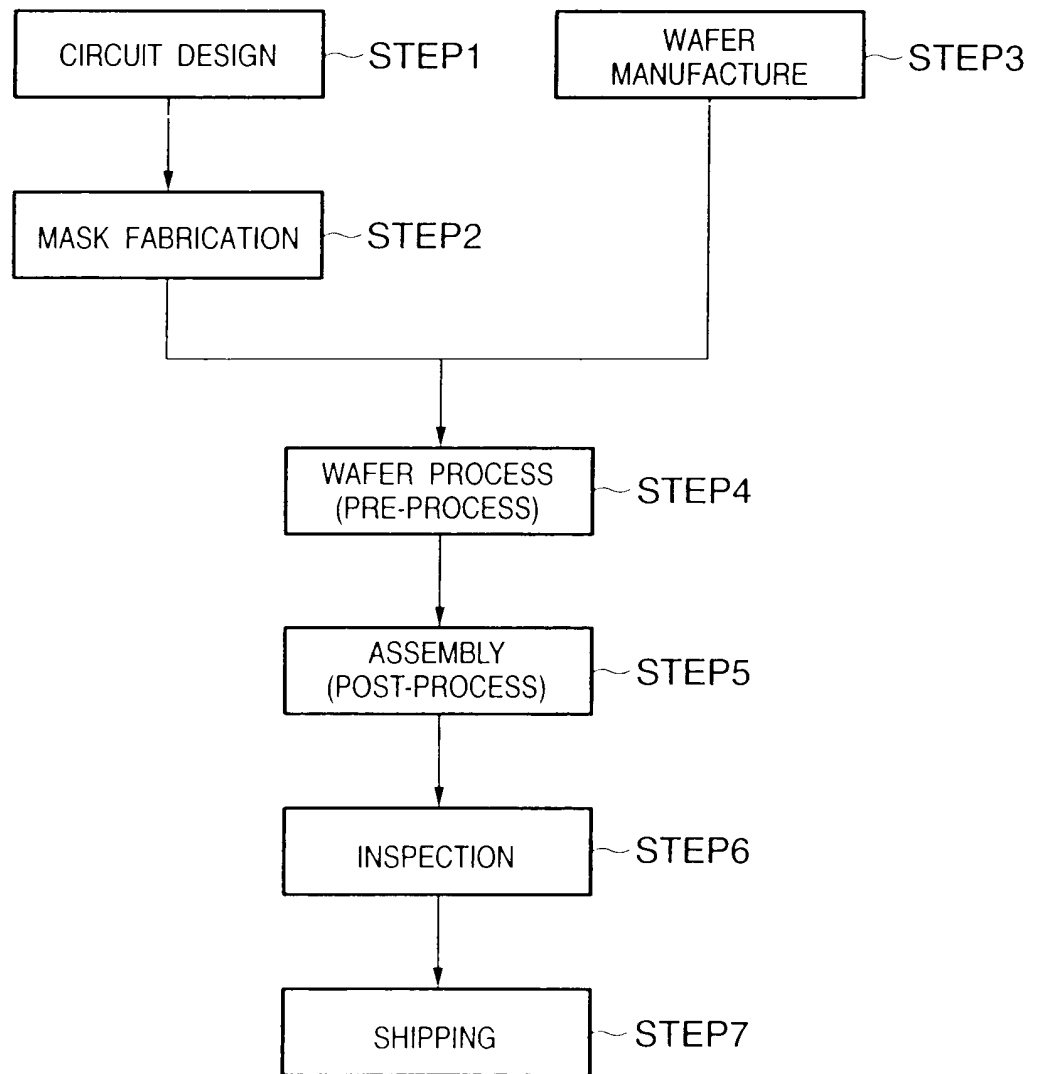
CONDITION ~ 406

COUNTERMEASURE METHOD ~ 407

PROGRESS REPORT ~ 408

410 411 412

[LINK TO DATABASE OF RESULTS](#) [SOFTWARE LIBRARY](#) [OPERATING GUIDE](#)

FIG. 7

SEMICONDUCTOR DEVICE MANUFACTURING FLOW

FIG. 8

